

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE PATENT APPLICATION

Appl. No. .

10/731,714

Confirmation No. TBD

Applicant

Agashe et al.

Filed:

December 9, 2003

TC/A.U.

TBD

Examiner

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Docket No.

TI-36268

Customer No.

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Mail Stop Patent Application Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

CERTIFICATE OF MAILING UNDER 37 CFR 1.8

I hereby certify that the attached document is being deposited with the United States Postal Service with sufficient postage for First Class Mail in an envelope addressed to Commissioner for Patents Alexandria, VA 22313-1450 on:

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## INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97 & 1.98

Sir:

Applicants wish to bring to the attention of the Patent and Trademark Office the information noted on the enclosed PTO Form 1449. Pursuant to the new rules, copies of the U.S. Patents herein noted are not enclosed.

Please charge any fees due in connection with the filing of this paper to the deposit account of Texas Instruments Incorporated, Account No. 20-0668. Please credit any excess fees to the same deposit account.

Respectfully submitted,

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